Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination ARAKAWA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
1	М	US-		j	
	—_L				

FOREIGN PATENT DOCUMENTS

* Document Number Date					
	Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 09-087526 A	03-1997	Japan	Haraguchi et al	
0	JP 08-283425 A	10-1996	Japan		
Р					
Q					
R		ļ			
s					
Т					
	O P Q R s	N JP 09-087526 A O JP 08-283425 A P Q R S	Country Code-Number-Kind Code MM-YYYY N JP 09-087526 A 03-1997 O JP 08-283425 A 10-1996 P Q R S	Country Code-Number-Kind Code MM-YYYY Country N JP 09-087526 A 03-1997 Japan O JP 08-283425 A 10-1996 Japan P	Country Code-Number-Kind Code MM-YYYY Country Name N JP 09-087526 A 03-1997 Japan Haraguchi et al. O JP 08-283425 A 10-1996 Japan Haraguchi et al. P Country Country Country Name Name Country

NON-PATENT DOCUMENTS

*		The second of th
	-	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	- V	
	w	
	х	
'A con	v of thi	S (afarance is not being firm;). I was a second of the se

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.